

<b>Notice of References Cited</b>	Application/Control No. 10/514,429		Applicant(s)/Patent Under Reexamination DWILINSKI ET AL.	
	Examiner MICHAEL J. LOGIE		Art Unit 2881	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,249,534 B1	06-2001	Itoh et al.	372/49.01
*	B	US-2002/0028564 A1	03-2002	Motoki et al.	438/460
*	C	US-6,592,663 B1	07-2003	Sarayama et al.	117/68
*	D	US-2004/0031978 A1	02-2004	D'Evelyn et al.	257/233
*	E	US-7,132,730 B2	11-2006	Dwili ski et al.	257/615
*	F	US-7,420,261 B2	09-2008	Dwili ski et al.	257/615
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002241112 A	08-2002	Japan	TABATA et al.	C01B 21/06
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

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